ON Semiconductor

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ON Semiconductor®

FDD6N50TM-F085

500V N-Channel MOSFET

Features

- 6A, 500V, $R_{DS(on)} = 0.9\Omega$ @ $V_{GS} = 10 \text{ V}$
- Low gate charge (typical 12.8 nC)
- Low C_{rss} (typical 9 pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · Qualified to AEC Q101
- · RoHS Compliant

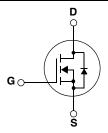


Description

These N-Channel enhancement mode power field effect transistors are produced using ON Semiconductor's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.





Absolute Maximum Ratings

Symbol	Parameter		Ratings	Unit	
V _{DSS}	Drain-Source Volta	ge		500	V
I _D	Drain Current	- Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		6 3.8	A A
I _{DM}	Drain Current	- Pulsed	(Note 1)	24	А
V _{GSS}	Gate-Source voltage		±30	V	
E _{AS}	Single Pulsed Aval	anche Energy	(Note 2)	270	mJ
I _{AR}	Avalanche Current		(Note 1)	6	А
E _{AR}	Repetitive Avalance	he Energy	(Note 1)	8.9	mJ
dv/dt	Peak Diode Recov	ery dv/dt	(Note 3)	4.5	V/ns
P_D	Power Dissipation	(T _C = 25°C) - Derate above 25°C		89 0.71	W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	Min.	Max.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		83	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD6N50	FDD6N50TM-F085	D-PAK	380mm	16mm	2500

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Units	
Off Charac	Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage $V_{GS} = 0V, I_D = 250\mu A$		500			V	
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.5		V/°C	
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 500V, V_{GS} = 0V$ $V_{DS} = 400V, T_C = 125^{\circ}C$			1 10	μ Α μ Α	
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{DS} = 0V	-		100	nA	
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V			-100	nA	
On Charac	teristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V	
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 3A		0.76	0.9	Ω	
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 3A$ (Note 4)		2.5		S	
Dynamic C	Characteristics					•	
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$		720	940	pF	
C _{oss}	Output Capacitance	f = 1.0MHz		95	190	pF	
C _{rss}	Reverse Transfer Capacitance			9	13.5	pF	
Switching	Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 250V, I _D = 6A	1	6	20	ns	
t _r	Turn-On Rise Time	$R_G = 25\Omega$		55	120	ns	
t _{d(off)}	Turn-Off Delay Time			25	60	ns	
t _f	Turn-Off Fall Time	(Note 4, 5)		35	80	ns	
Q_g	Total Gate Charge	$V_{DS} = 400V, I_{D} = 6A$		12.8	16.6	nC	
Q_{gs}	Gate-Source Charge	V _{GS} = 10V		3.7		nC	
Q_{gd}	Gate-Drain Charge (Note 4, 5)			5.8		nC	
Drain-Sour	rce Diode Characteristics and Maximun	n Ratings		1			
I _S Maximum Continuous Drain-Source Diode Forward Current					6	Α	
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				24	Α	
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 6A			1.4	V	
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 6A		275		ns	
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s $ (Note 4)		1.7		μС	

NOTES:

 $^{{\}it 1. Repetitive \ Rating: Pulse \ width \ limited \ by \ maximum \ junction \ temperature}$

^{2.} I $_{AS}$ = 6A, V $_{DD}$ = 50V, L=13.5mH, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25 $^{\circ}$ C

^{3.} I_{SD} \leq 6A, di/dt \leq 200A/µs, V_{DD} \leq BV_DSS, Starting T_J = 25°C

^{4.} Pulse Test: Pulse width $\leq 300 \mu \text{s}, \, \text{Duty Cycle} \leq 2\%$

^{5.} Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

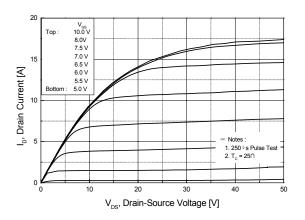


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

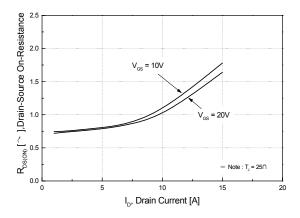


Figure 5. Capacitance Characteristics

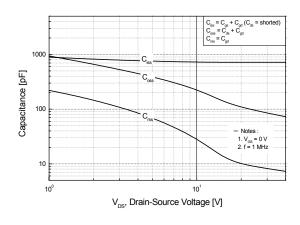


Figure 2. Transfer Characteristics

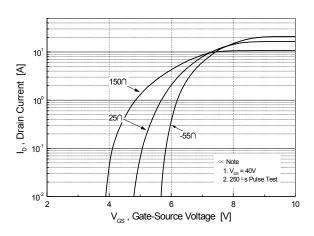


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

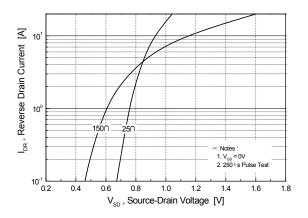
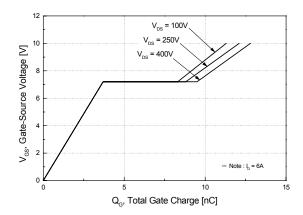


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

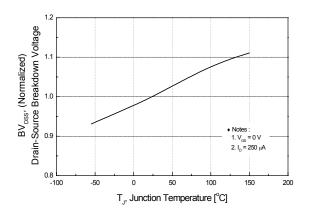


Figure 8. On-Resistance Variation vs. Temperature

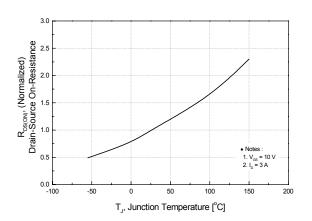


Figure 9. Maximum Safe Operating Area

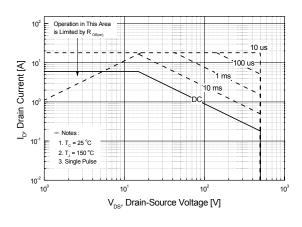


Figure 10. Maximum Drain Current vs. Case Temperature

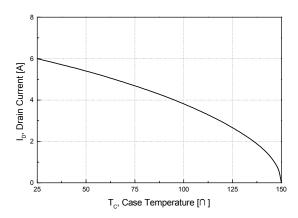
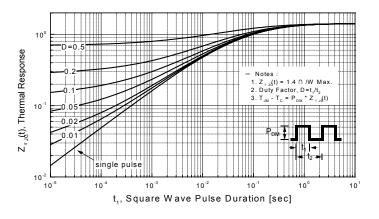
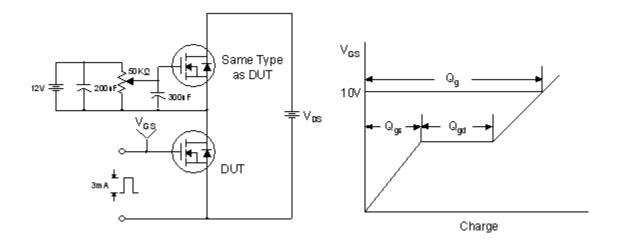


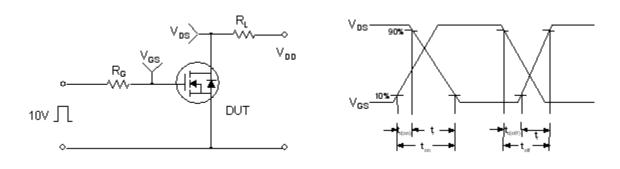
Figure 11. Transient Thermal Response Curve



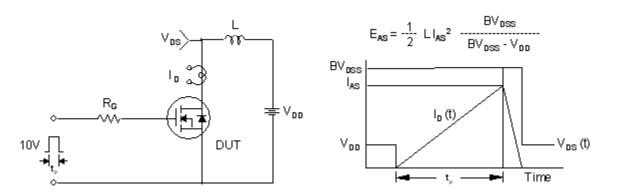
Gate Charge Test Circuit & Waveform



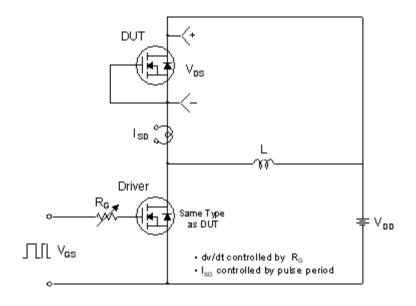
Resistive Switching Test Circuit & Waveforms

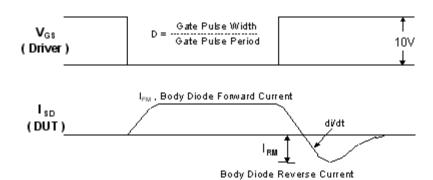


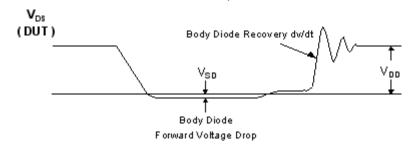
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

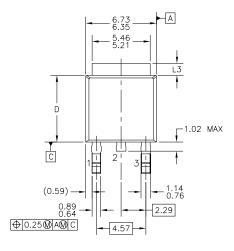


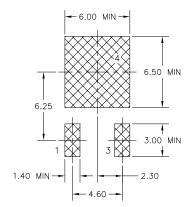




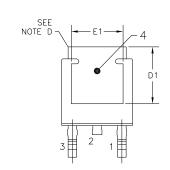
Mechanical Dimensions

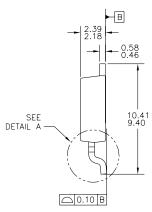
D-PAK

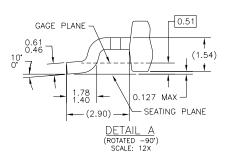




LAND PATTERN RECOMMENDATION







- NOTES: UNLESS OTHERWISE SPECIFIED

 A) ALL DIMENSIONS ARE IN MILLIMETERS.

 B) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999.

 C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

 D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.

 E) DIMENSIONS L3,D,E1&D1 TABLE:

 [OPTION ART | OPTION ART]

DINELIADIONS ES,D,ETOEDT IN				
		OPTION AA	OPTION AB	
	L3	0.89-1.27	1.52-2.03	
	D	5.97-6.22	5.33-5.59	
	E1	4.32 MIN	3.81 MIN	
	D1	5.21 MIN	4.57 MIN	

F) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL.

Dimensions in Millimeters

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